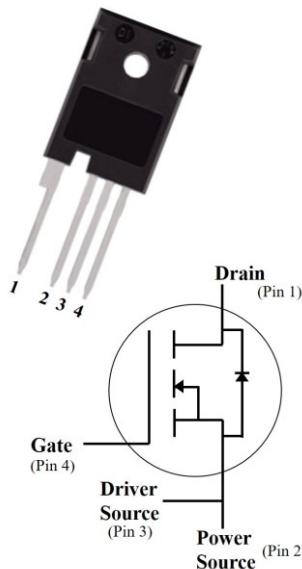


**Silicon Carbide Power MOSFET (N-Channel Enhancement)**

|                       |       |
|-----------------------|-------|
| V <sub>DS</sub>       | 1200V |
| I <sub>D (25°C)</sub> | 66A   |
| R <sub>DS(on)</sub>   | 33mΩ  |

**Features**

- High speed switching
- Essentially no switching losses
- Reduction of heat sink requirements
- Maximum working temperature at 175 °C
- High blocking voltage
- Fast Intrinsic diode with low recovery current
- High-frequency operation
- Halogen free, RoHS compliant

**Typical Applications**

Typical applications are in power factor correction(PFC), solar inverter, uninterruptible power supply, motor drives, photovoltaic inverter, electric car and charger.

**Mechanical Data**

- **Package:** TO247-4L
- **Terminals:** Tin plated leads
- **Polarity:** As marked

**■Maximum Ratings (T<sub>c</sub>=25°C Unless otherwise specified)**

| PARAMETER  | SYMBOL                            | UNIT | VALUE       | TEST CONDITIONS  | NOTE    |
|--|-----------------------------------|------|-------------|--|---------|
| Device marking code                              |                                   |      |             | D212040NCFG2   |         |
| Drain source voltage @ T <sub>j</sub> =25°C      | V <sub>DS,max</sub>               | V    | 1200        | V <sub>GS</sub> =0 V, I <sub>D</sub> =100uA              |         |
| Gate source voltage @ T <sub>j</sub> =25°C       | V <sub>GS,max</sub>               | V    | -8/+19      | Absolute maximum values                                  |         |
| Gate source voltage @ T <sub>j</sub> =25°C       | V <sub>GS,op</sub>                | V    | -4/+15      | Recommended operational values                           | Note1、2 |
| Continuous drain current @ T <sub>c</sub> =25°C  | I <sub>D</sub>                    | A    | 66          | V <sub>GS</sub> =15V, T <sub>c</sub> =25°C               | Fig.18  |
| Continuous drain current @ T <sub>c</sub> =100°C |                                   |      | 48          | V <sub>GS</sub> =15V, T <sub>c</sub> =100°C              |         |
| Pulsed drain current                             | I <sub>D(pulsed)</sub>            | A    | 120         | Pulse width t <sub>p</sub> limited by T <sub>j,max</sub> | Fig.23  |
| Power Dissipation                                | P <sub>TOT</sub>                  | W    | 333         | T <sub>c</sub> =25°C , T <sub>j</sub> = 175°C            | Fig.17  |
| Power Dissipation                                |                                   |      | 144         | T <sub>c</sub> =110°C, T <sub>j</sub> = 175°C            |         |
| Operating junction and Storage temperature range | T <sub>j</sub> , T <sub>stg</sub> | °C   | -55 to +175 |  |         |
| Soldering temperature                            | T <sub>L</sub>                    | °C   | 260         | 1.6mm (0.063") from case for 10s                         |         |
| Mounting torque                                  | T <sub>M</sub>                    | Nm   | 0.6         | M3 screw Maximum of mounting process: 3                  |         |



## ■ Static Electrical Characteristics (Tc=25°C unless otherwise specified)

| PARAMETER                                | SYMBOL               | UNIT | Min. | Typ. | Max. | Test Conditions  | Note        |
|--|----------------------|------|------|------|------|--|-------------|
| Gate threshold voltage                   | V <sub>GS(th)</sub>  | V    | 2.0  | 2.5  | 3.5  | V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> = 11.5mA           | Fig.4, 11   |
|  |                      |      |      | 2.0  |      | V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> = 11.5mA, Tj=175°C |             |
| Drain source breakdown voltage           | V <sub>(BR)DSS</sub> | V    | 1200 |      |      | V <sub>GS</sub> =0, I <sub>D</sub> =100uA                            |             |
| Zero gate voltage drain current          | I <sub>DSS</sub>     | uA   |      | 1    | 50   | V <sub>DS</sub> =1200V, V <sub>GS</sub> = 0V                         | Fig.16      |
| Gate source leakage current              | I <sub>GSS</sub>     | nA   |      | 10   | 100  | V <sub>GS</sub> = 15V, V <sub>DS</sub> =0V                           |             |
| Current drain source on-state resistance | R <sub>DS ON</sub>   | mΩ   |      | 33   | 44   | V <sub>GS</sub> =15V, I <sub>D</sub> =40A                            | Fig.5, 6, 7 |
|  |                      |      |      | 63   |      | V <sub>GS</sub> =15V, I <sub>D</sub> =40A, Tj=175°C                  |             |
| Internal gate resistance                 | R <sub>g</sub>       | Ω    |      | 1.8  |      | f=1MHz   |             |
| Diode forward voltage                    | V <sub>SD</sub>      | V    |      | 5.0  |      | V <sub>GS</sub> =-4V, I <sub>SD</sub> =20A                           | Fig.8       |
|  |                      |      |      | 3.3  |      | V <sub>GS</sub> =0V, I <sub>SD</sub> =20A<br>Tj=175°C                | Fig.9       |
| Transconductance                         | g <sub>r</sub>       | S    |      | 26   |      | V <sub>DS</sub> =20V, I <sub>D</sub> =40A                            | Fig.4       |
|  |                      |      |      | 22   |      | V <sub>DS</sub> =20V, I <sub>D</sub> =40A, Tj=175°C                  |             |

## ■ Dynamic Electrical Characteristics (Tc=25°C unless otherwise specified)

| PARAMETER                      | SYMBOL           | UNIT | Min. | Typ. | Max. | Test Conditions  | Note       |
|--------------------------------|------------------|------|------|------|------|--|------------|
| Input capacitance              | C <sub>iss</sub> | pF   |      | 3456 |      | V <sub>DS</sub> =1000V, V <sub>GS</sub> =0V, Tj=25°C,<br>f=100 kHz, V <sub>AC</sub> = 25mV | Fig.13, 14 |
| Output capacitance             | C <sub>oss</sub> |      |      | 127  |      |  |            |
| Reverse capacitance            | C <sub>rss</sub> |      |      | 7.2  |      |  |            |
| C <sub>oss</sub> stored energy | E <sub>oss</sub> | uJ   |      | 69   |      | V <sub>DS</sub> =800V, V <sub>GS</sub> =-4/15V, I <sub>D</sub> =40A                        | Fig.15     |
| Gate source charge             | Q <sub>gs</sub>  | nC   |      | 39   |      |  | Fig.12     |
| Gate drain charge              | Q <sub>gd</sub>  |      |      | 44   |      |  |            |
| Gate charge                    | Q <sub>g</sub>   |      |      | 116  |      |  |            |

## ■ Switching Characteristics (Tc=25°C unless otherwise specified)

| PARAMETER                 | SYMBOL             | UNIT | Min. | Typ. | Max. | Test Conditions   | Note       |
|---------------------------|--------------------|------|------|------|------|---|------------|
| Turn on switching energy  | E <sub>on</sub>    | uJ   |      | 500  |      | V <sub>DD</sub> =800V, V <sub>GS</sub> =-4/+15V, I <sub>D</sub> =40A,<br>R <sub>g</sub> =2.5Ω, L=65uH | Fig.21, 22 |
| Turn off switching energy | E <sub>off</sub>   |      |      | 80   |      |   |            |
| Turn on delay time        | t <sub>d(on)</sub> | ns   |      | 23   |      |   |            |
| Rise time                 | t <sub>r</sub>     |      |      | 20   |      |   |            |

|                     |              |    |    |  |  |            |
|---------------------|--------------|----|----|--|--|------------|
| Turn off delay time | $t_{d(off)}$ | ns | 31 |  | $V_{DD}=800V, V_{GS}=-4/+15V, I_D=40A, R_g=2.5\Omega, L=65\mu H$ | Fig.21, 22 |
| Fall time           | $t_f$        |    | 8  |  |  |            |

### ■Body diode characteristics (Tc=25°C unless otherwise specified)

| PARAMETER                        | SYMBOL    | UNIT | Min. | Typ. | Max. | Test Conditions                                    | Note  |
|----------------------------------|-----------|------|------|------|------|--|-------|
| Diode forward voltage            | $V_{SD}$  | V    |      | 5.0  |      | $V_{GS}=-4V, I_{SD}=20A$                           | Fig.8 |
|                                  |           |      |      | 3.3  |      | $V_{GS}=0V, I_{SD}=20A, T_j=175^{\circ}C$          | Fig.9 |
| Continuous diode forward current | $I_s$     | A    |      | 66   |      | $T_c=25^{\circ}C$                                  | Note1 |
| Reverse recovery time            | $t_{rr}$  | nS   |      | 27   |      |  |       |
| Reverse recovery charge          | $Q_{rr}$  | nC   |      | 478  |      | $V_R=800V, V_{GS}=-4V, I_D=40A, dI/dt=2250A/\mu s$ |       |
| Peak reverse recovery current    | $I_{rrm}$ | A    |      | 27   |      |  |       |

Note 1: When using SiC Body Diode the maximum recommended  $V_{GS} = -4V$

Note 2: MOSFET can also safely operate at 0/15 V

### ■Thermal Characteristics (Ta=25°C Unless otherwise specified)

| PARAMETER          | SYMBOL           | UNIT | Typ. |
|--------------------|------------------|------|------|
| Thermal resistance | $R_{\theta J-C}$ | °C/W | 0.45 |

### ■Typical Characteristics

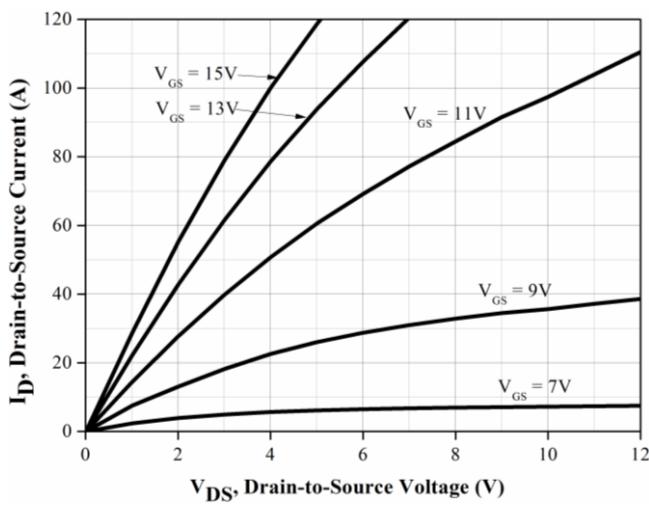


Figure 1. Output Characteristics  $T_j = -55^{\circ}C$

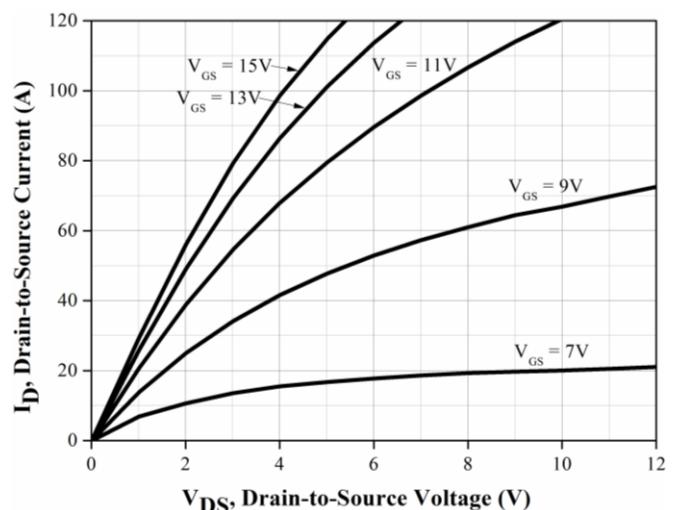


Figure 2. Output Characteristics  $T_j = 25^{\circ}C$

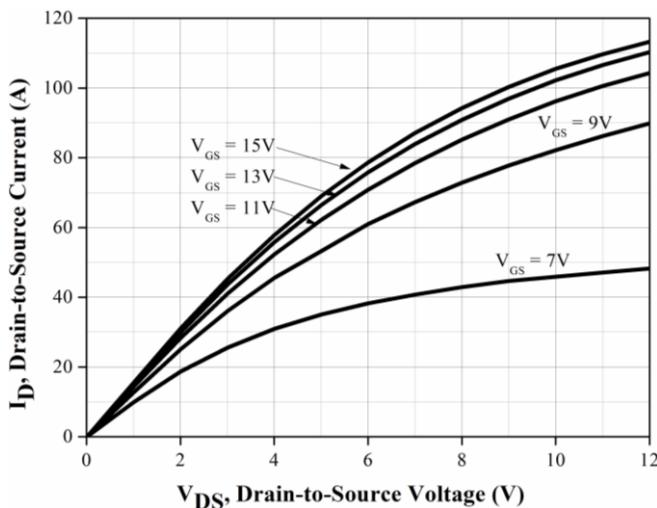


Figure 3. Output Characteristics  $T_j = 175^\circ\text{C}$

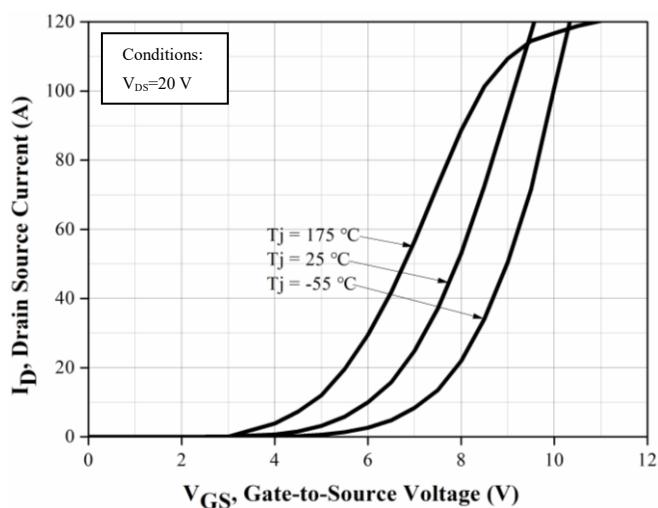


Figure 4. Transfer Characteristics for various junction temperature

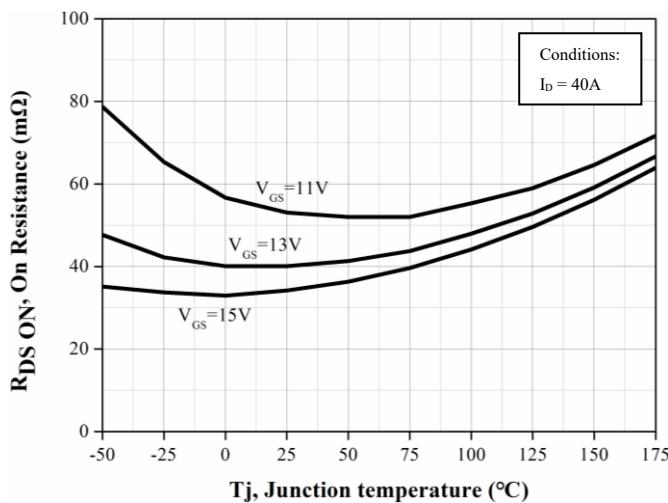


Figure 5. On-resistance vs. temperature for various gate voltage

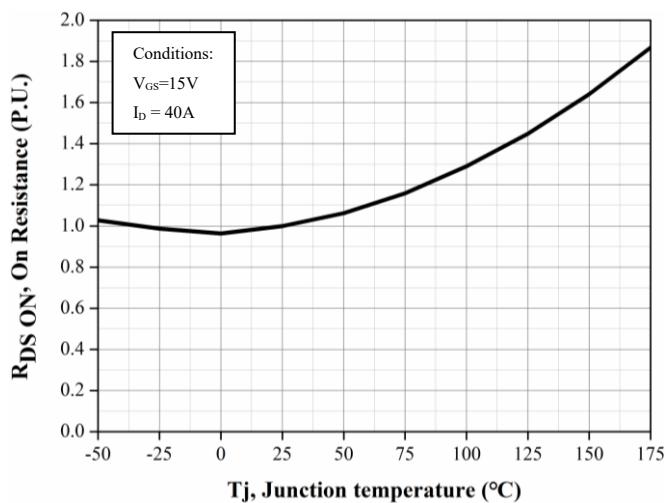


Figure 6. Normalized on-resistance vs. temperature

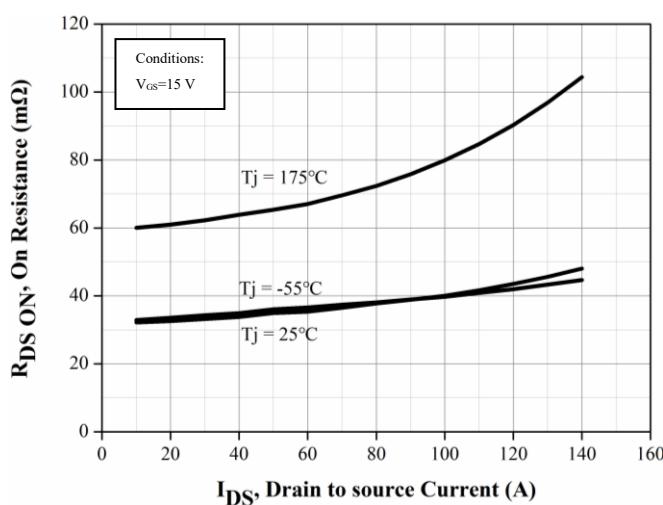


Figure 7. On-resistance vs. drain current

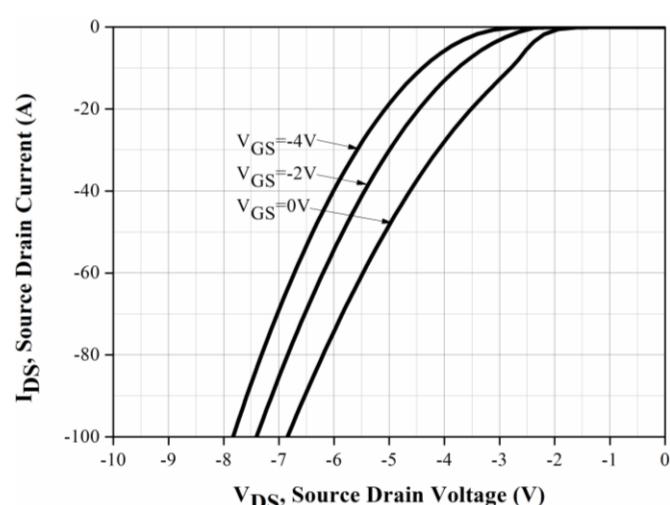


Figure 8. Body diode characteristic at  $T_j = 25^\circ\text{C}$

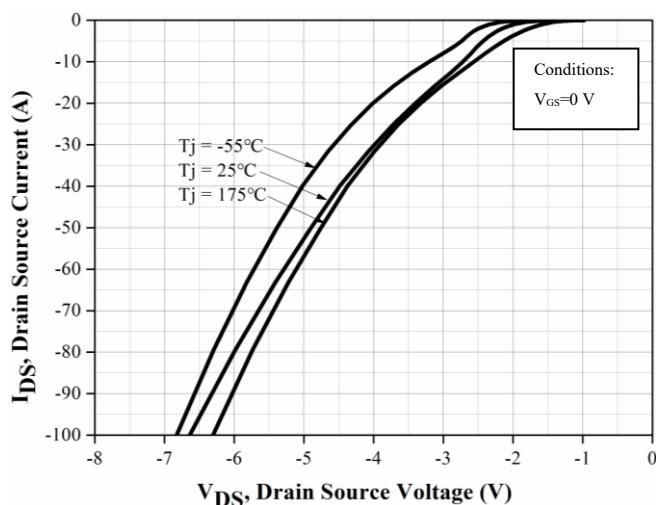


Figure 9. Body diode characteristic

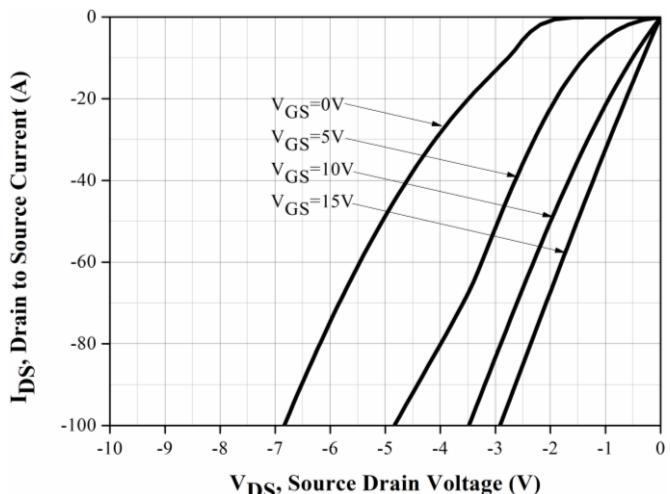


Figure 10. 3<sup>rd</sup> quadrant characteristic at  $T_j = 25^\circ\text{C}$

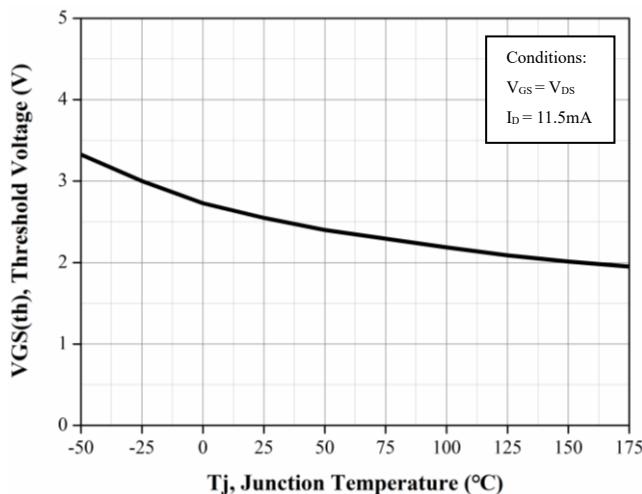


Figure 11. Threshold voltage vs. temperature

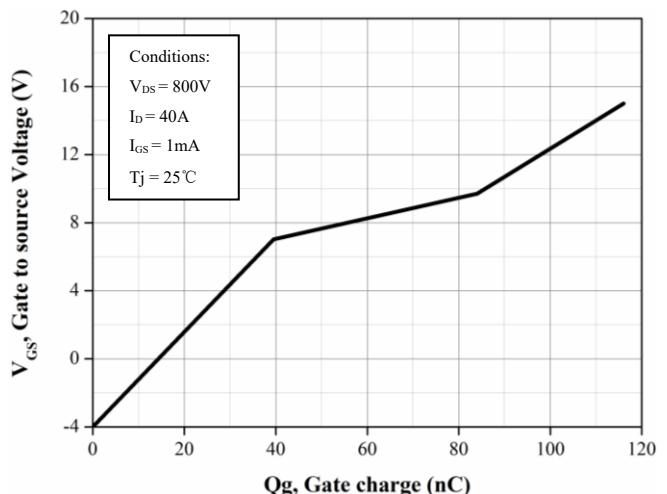


Figure 12. Gate charge characteristic

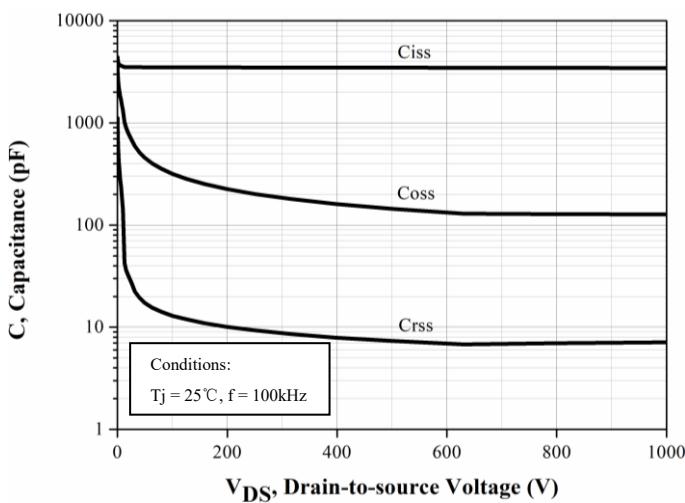


Figure 13. Capacitances vs. drain source voltage (0-1000V)

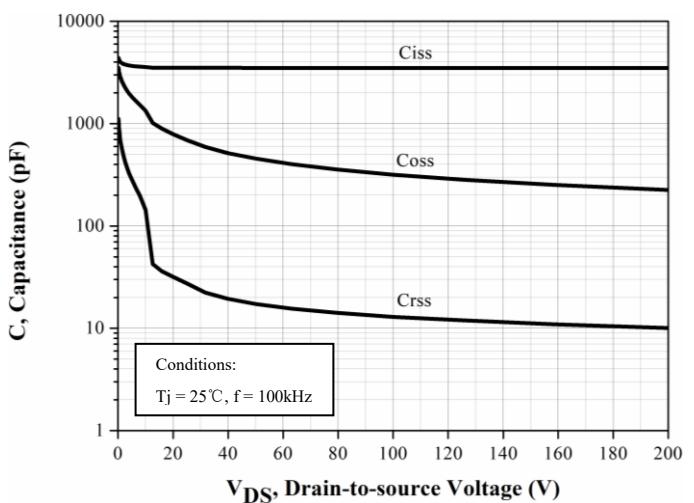
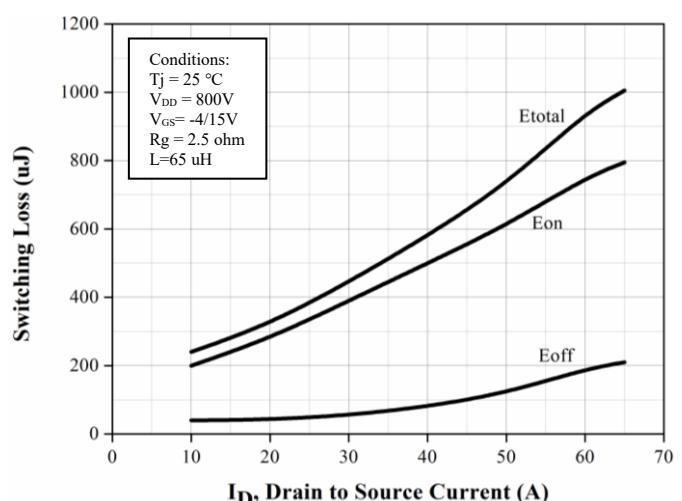
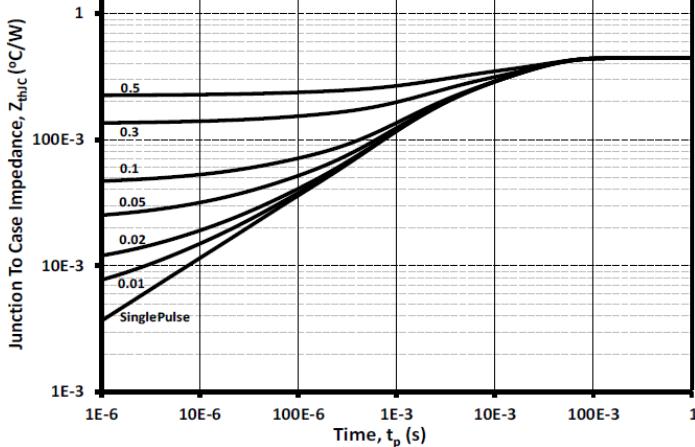
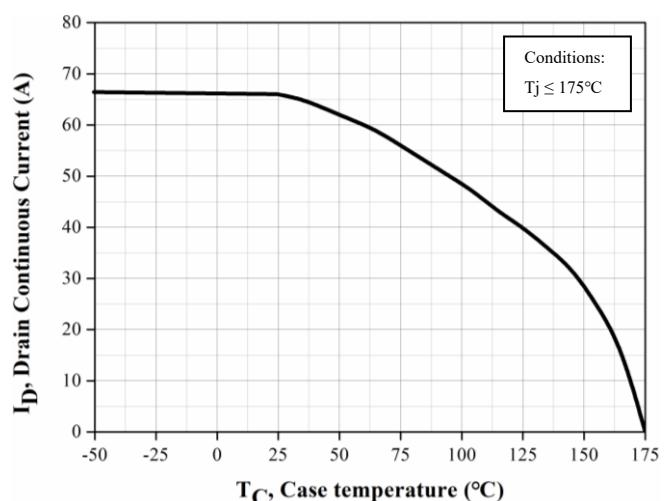
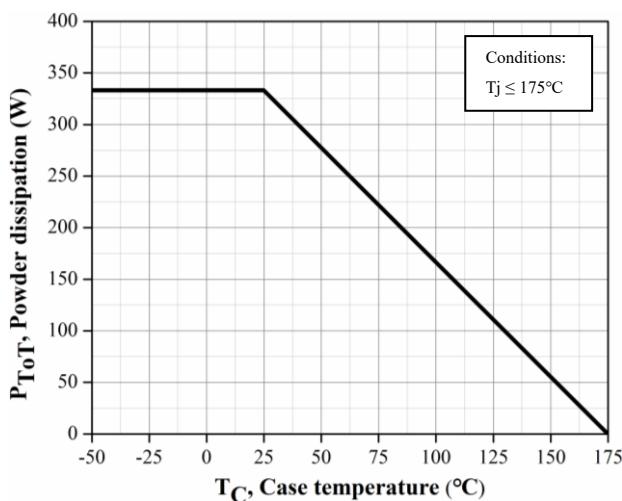
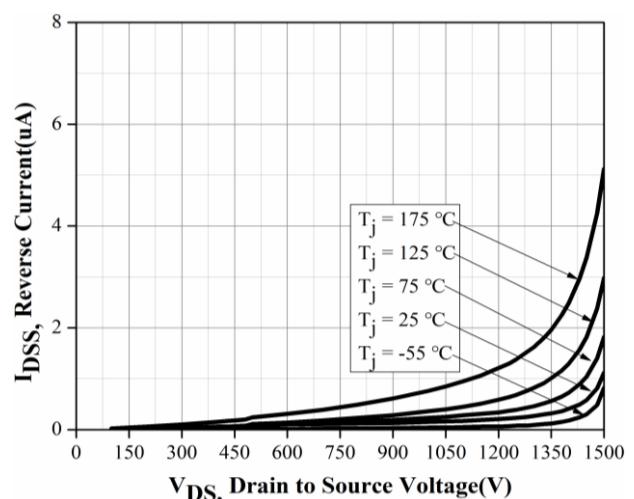
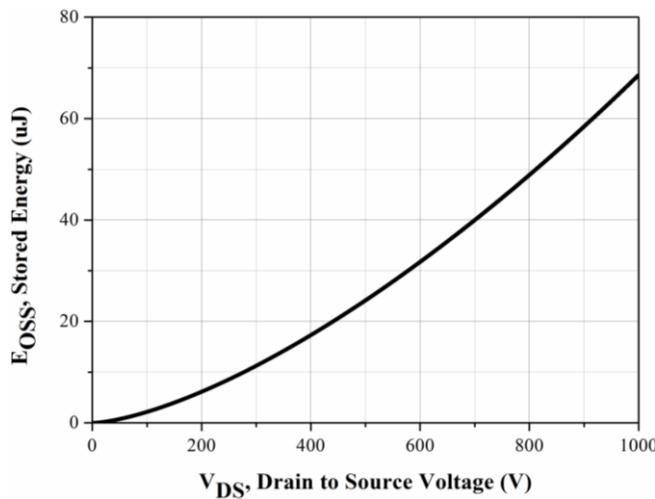


Figure 14. Capacitances vs. drain source voltage (0-200V)



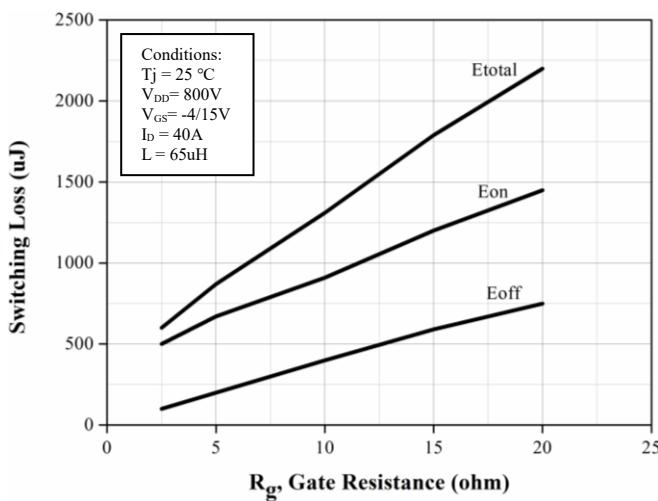


Figure 21. Clamped inductive switching energy vs.  $R_g$

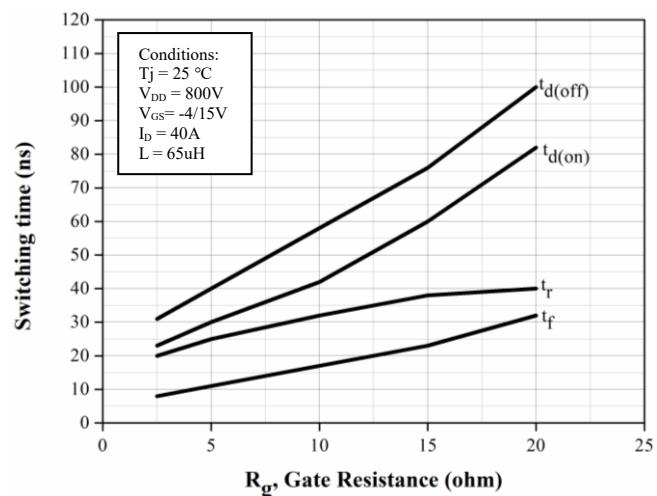


Figure 22. Switching times vs.  $R_g$

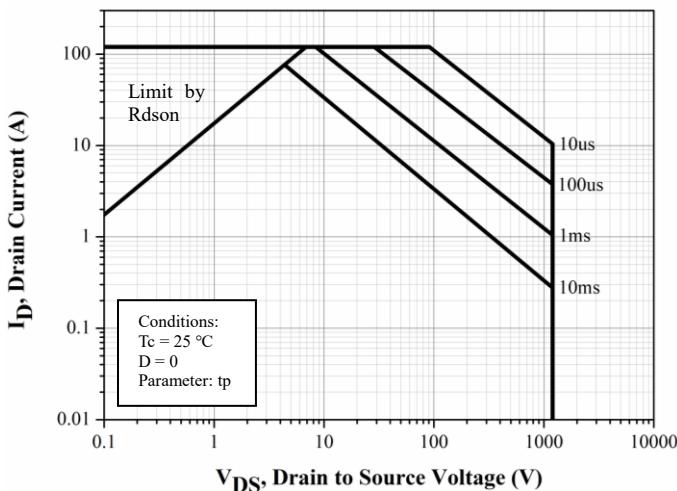


Figure 23. Safe Operating Area

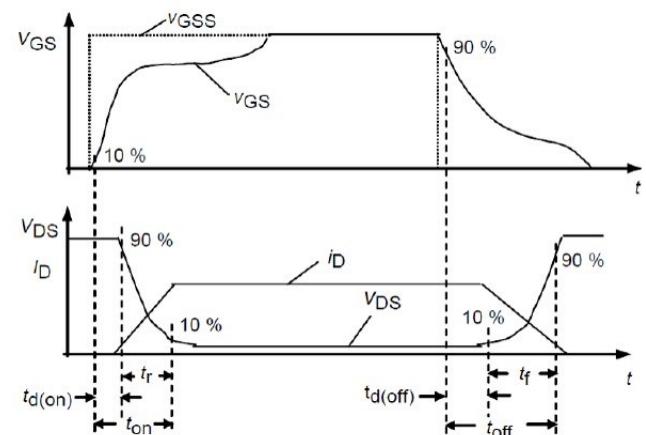


Figure 24. Switching Times Definition

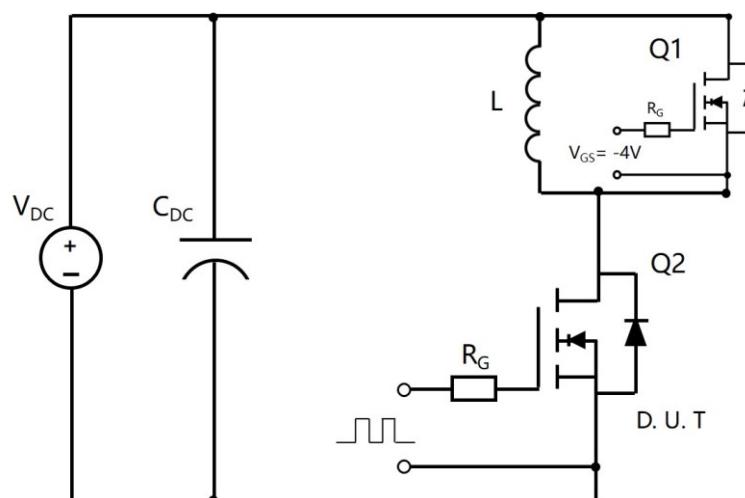
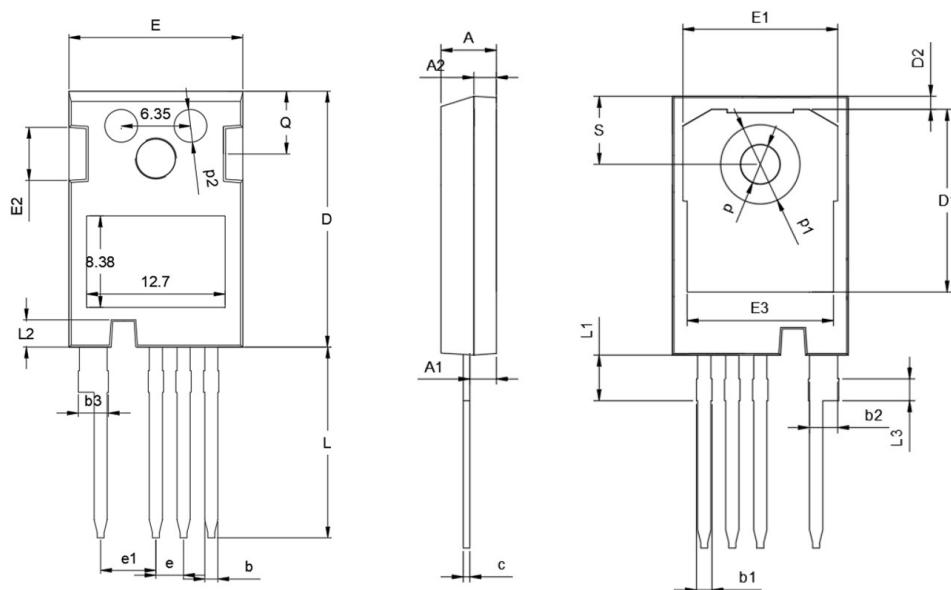


Figure 25. Clamped Inductive Switching Waveform Test Circuit

## ■Outline Dimensions



| TO247-4L |         |       |       |
|----------|---------|-------|-------|
| Dim      | Min     | Norm  | Max   |
| A        | 4.80    | 5.00  | 5.20  |
| A1       | 2.30    | 2.40  | 2.50  |
| A2       | 1.88    | 1.98  | 2.08  |
| b        | 1.10    | 1.20  | 1.30  |
| b1       | 1.20    | /     | 1.50  |
| b2       | 2.35    | 2.55  | 2.75  |
| b3       | 2.45    | /     | 2.85  |
| c        | 0.55    | 0.60  | 0.65  |
| D        | 23.3    | 23.45 | 23.6  |
| D1       | 16.25   | 16.55 | 16.85 |
| D2       | 1.00    | /     | 1.30  |
| e        | TYP2.54 |       |       |
| e1       | TYP5.06 |       |       |
| E        | 15.75   | 15.90 | 16.05 |
| E1       | 13.80   | /     | 14.20 |
| E2       | 4.40    | 4.75  | 5.10  |
| E3       | 13.00   | /     | 13.45 |
| L        | 17.34   | 17.49 | 17.64 |
| L1       | 4.00    | /     | 4.30  |
| L2       | 2.35    | /     | 2.65  |
| L3       | TYP1.98 |       |       |
| Q        | 5.60    | 5.80  | 6.00  |
| S        | 6.05    | /     | 6.30  |
| p        | TYP3.58 |       |       |
| p1       | TYP7.18 |       |       |
| p2       | TYP3.00 |       |       |



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